October 1998



SEMICONDUCTOR TM

# FDS6930A

# Dual N-Channel, Logic Level, PowerTrench<sup>™</sup> MOSFET

# **General Description**

These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

## Features

- Fast switching speed.
- Low gate charge (typical 5 nC).
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.

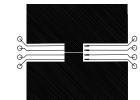
	ân (11)				
so	T-23 SuperSOT <sup>™</sup> -6	SuperSOT <sup>™</sup> -8	so-8	SOT-223	SOIC-16
	D1 D1 ED2 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5	S2 <sup>G2</sup>	[ [ [		4 3 2 1
	Te Maximum Ratings $T_A = 25^{\circ}$	C unless otherwise note	ed	FDS6930A	Units
mbol		C unless otherwise not	d	<b>FDS6930A</b> 30	Units V
m <b>bol</b>	Parameter	C unless otherwise note	ed		
m <b>bol</b>	Parameter Drain-Source Voltage	C unless otherwise not	ed	30	V
m <b>bol</b>	Parameter Drain-Source Voltage Gate-Source Voltage		ed	30 ±20	V V
rmbol ss ss	Parameter Drain-Source Voltage Gate-Source Voltage Drain Current - Continuous	(Note 1a)	ed	30 ±20 5.5	V V
rmbol ss ss	Parameter Drain-Source Voltage Gate-Source Voltage Drain Current - Continuous - Pulsed	(Note 1a)	ed	30 +20 5.5 20	V V A
vmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a)	ed	30 ±20 5.5 20 2	V V A W
rmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a) (Note 1) IN (Note 1a)	ed	30 +20 5.5 20 2 1.6	V V A W
rmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a) (Note 1) (Note 1a) (Note 1a) (Note 1b) (Note 1c)	ed	30 ±20 5.5 20 2 1.6 1	V V A W
rmbol ss ss T <sub>STG</sub>	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation         Power Dissipation for Single Operation	(Note 1a) (Note 1) (Note 1a) (Note 1a) (Note 1b) (Note 1c)		30 ±20 5.5 20 2 1.6 1 0.9	V           V           A           W           W
rmbol sss sss T <sub>STG</sub>	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation         Power Dissipation for Single Operation         Operating and Storage Temperature I	(Note 1a) (Note 1) n (Note 1a) (Note 1b) (Note 1c) Range	ed	30 ±20 5.5 20 2 1.6 1 0.9	V           V           A           W           W

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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS	·		•	•	•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$		30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{D}$ = 250 µA, Referenced t	o 25 °C		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$				1	μA
			T <sub>J</sub> = 55°C			10	μA
	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate - Body Leakage, Reverse	$V_{gs} = -20 \text{ V}, \text{ V}_{ds} = 0 \text{ V}$				-100	nA
ON CHARA	CTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1	1.5	3	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \ \mu$ A, Referenced to $25 \ ^{\circ}$ C			-4		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5.5 \text{ A}$			0.032	0.04	Ω
			T <sub>J</sub> =125°C		0.048	0.068	
		$V_{GS} = 4.5 \text{ V}, \ \text{I}_{D} = 4.8 \text{ A}$	•		0.044	0.055	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$		20			А
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 5.5 \text{ A}$			12		S
DYNAMIC (	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$			460		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz			115		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				45		pF
SWITCHING	CHARACTERISTICS (Note 2)			•			
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = 15 \text{ V}, \ I_{D} = 1 \text{ A}$			5	11	ns
ţ,	Turn - On Rise Time	$V_{\rm GS} = 10 \ V \ , \ R_{\rm GEN} = 6 \ \Omega$			8	17	ns
t <sub>D(off)</sub>	Turn - Off Delay Time				17	28	ns
t <sub>r</sub>	Turn - Off Fall Time				13	24	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 5 V, I_{D} = 5.5 A,$			5	7	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$			2		nC
Q <sub>gd</sub>	Gate-Drain Charge				0.9		nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS					
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current					1.3	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 1.3 A$ (Note	2)			1.2	V

Notes:

1. R<sub>g,k</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>g,k</sub> is guaranteed by design while R<sub>g,k</sub> is determined by the user's board design.



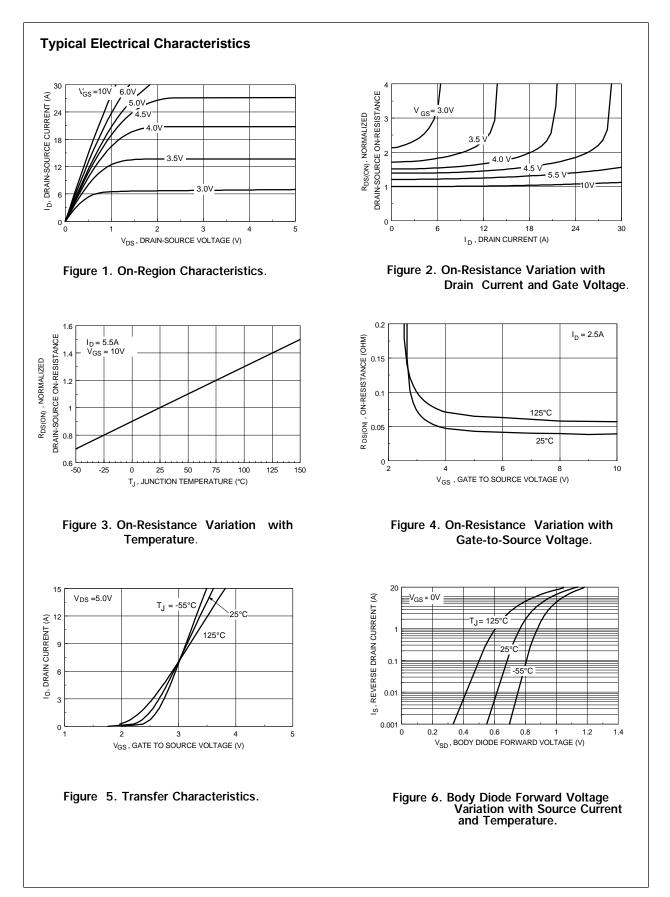


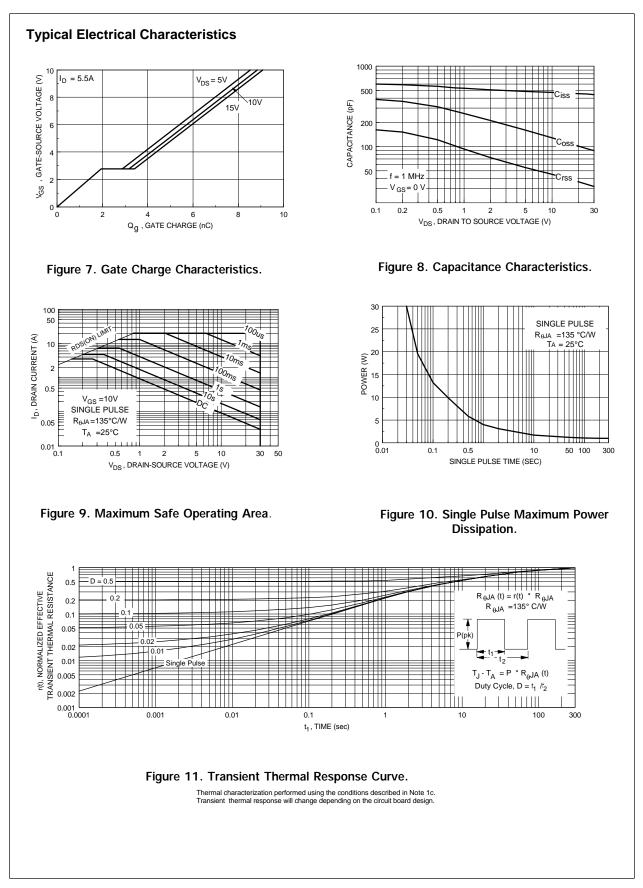
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b. 125°C/W on a 0.02 in<sup>2</sup> pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2.0%.





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